Low-Voltage 1.8/2.5/3.3V 16-Bit Buffer

With 3.6 V – Tolerant Inputs and Outputs (3–State, Inverting)

The 74VCXH16240 is an advanced performance, inverting 16-bit buffer. It is designed for very high-speed, very low-power operation in 1.8 V, 2.5 V or 3.3 V systems.

When operating at 2.5 V (or 1.8 V) the part is designed to tolerate voltages it may encounter on either inputs or outputs when interfacing to 3.3 V busses. It is guaranteed to be overvoltage tolerant to 3.6 V.

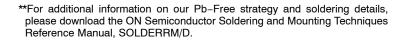
The 74VCXH16240 is nibble controlled with each nibble functioning identically, but independently. The control pins may be tied together to obtain full 16-bit operation. The 3-state outputs are controlled by an Output Enable (\overline{OEn}) input for each nibble. When \overline{OEn} is LOW, the outputs are on. When \overline{OEn} is HIGH, the outputs are in the high impedance state. The data inputs include active bushold circuitry, eliminating the need for external pullup resistors to hold unused or floating inputs at a valid logic state.

Features

- Designed for Low Voltage Operation: $V_{CC} = 1.65 \text{ V} 3.6 \text{ V}$
- 3.6 V Tolerant Inputs and Outputs
- High Speed Operation: 2.5 ns max for 3.0 V to 3.6 V 3.0 ns max for 2.3 V to 2.7 V

6.0 ns max for 1.65 V to 1.95 V

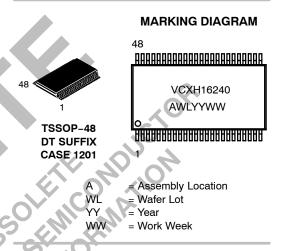
- Static Drive: ±24 mA Drive at 3.0 V
 ±18 mA Drive at 2.3 V
 ±6 mA Drive at 1.65 V
- Supports Live Insertion and Withdrawal
- Includes Active Bushold to Hold Unused or Floating Inputs at a Valid Logic State
- I_{OFF} Specification Guarantees High Impedance When $V_{CC} = 0 V^*$
- Near Zero Static Supply Current in All Three Logic States (20 μA) Substantially Reduces System Power Requirements
- Latchup Performance Exceeds ±250 mA @ 125°C
- ESD Performance: Human Body Model >2000 V Machine Model >200 V
- All Devices in Package TSSOP are Inherently Pb-Free**
- *To ensure the outputs activate in the 3-state condition, the output enable pins should be connected to V_{CC} through a pullup resistor. The value of the resistor is determined by the current sinking capability of the output connected to the \overline{OE} pin.





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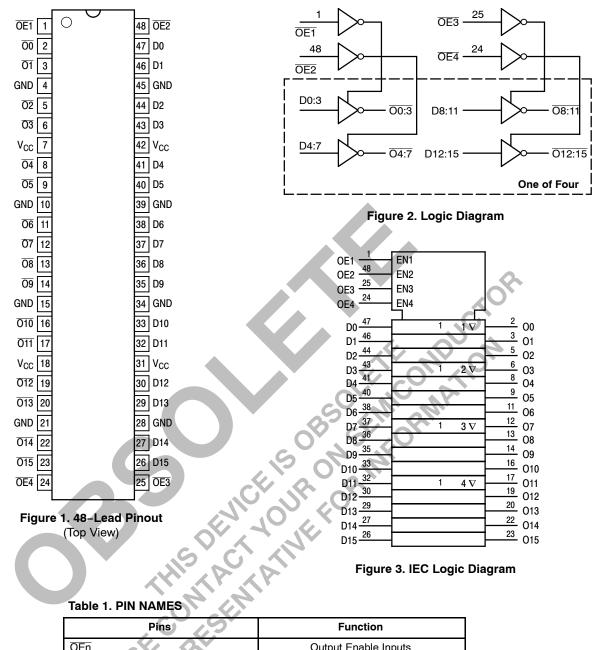


ORDERING INFORMATION

	Device	Package	Shipping [†]
	74VCXH16240DT	TSSOP (Pb-Free)	39 / Rail
Þ	74VCXH16240DTR	TSSOP (Pb–Free)	2500 / Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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PINS	Function
OEn D0-D15 O0-O15	Output Enable Inputs Inputs Outputs

TRUTH TABLE

OE1	D0:3	O0:3	OE2	D4:7	04:7	OE3	D8:11	08:11	OE4	D12:15	012:15
L	L	Н	L	L	Н	L	L	Н	L	L	Н
L	Н	L	L	Н	L	L	Н	L	L	Н	L
Н	Х	Z	Н	Х	Z	Н	Х	Z	Н	Х	Z

H = High Voltage Level

L = Low Voltage Level

Z = High Impedance State

X = High or Low Voltage Level and Transitions Are Acceptable, for I_{CC} reasons, DO NOT FLOAT Inputs

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Condition	Unit
V_{CC}	DC Supply Voltage	-0.5 to +4.6		V
VI	DC Input Voltage	$-0.5 \le V_{l} \le +4.6$		V
V _O	DC Output Voltage	$-0.5 \le V_0 \le +4.6$	Output in 3-State	V
		$-0.5 \leq V_{\rm O} \leq V_{\rm CC} + 0.5$	Note 1; Outputs Active	V
I _{IK}	DC Input Diode Current	-50	V _I < GND	mA
I _{OK}	DC Output Diode Current	-50	V _O < GND	mA
		+50	$V_{O} > V_{CC}$	mA
I _O	DC Output Source/Sink Current	±50		mA
I _{CC}	DC Supply Current Per Supply Pin	±100		mA
I _{GND}	DC Ground Current Per Ground Pin	±100		mA
T _{STG}	Storage Temperature Range	-65 to +150		°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. I_O absolute maximum rating must be observed.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min Typ	Max	Unit
V _{CC}	Supply Voltage Operating Data Retention Onl		3.6 3.6	V
VI	Input Voltage	-0.3	3.6	V
Vo	Output Voltage (Active State (3-State		V _{CC} 3.6	V
I _{OH}	HIGH Level Output Current, V _{CC} = 3.0 V – 3.6 V		-24	mA
l _{OL}	LOW Level Output Current, V _{CC} = 3.0 V – 3.6 V		24	mA
I _{OH}	HIGH Level Output Current, V _{CC} = 2.3 V – 2.7 V		-18	mA
I _{OL}	LOW Level Output Current, V _{CC} = 2.3 V – 2.7 V		18	mA
I _{ОН}	HIGH Level Output Current, V _{CC} = 1.65 V – 1.95 V		-6	mA
I _{OL}	LOW Level Output Current, V _{CC} = 1.65 V - 1.95 V		6	mA
T _A	Operating Free-Air Temperature	-40	+85	°C
$\Delta t/\Delta V$	Input Transition Rise or Fall Rate, V_{IN} from 0.8 V to 2.0 V, V_{CC} = 3.0 V	0	10	ns/V

DC ELECTRICAL CHARACTERISTICS

			$T_A = -40^\circ$	C to +85°C	
Symbol	Characteristic	Condition	Min	Max	Unit
V _{IH}	HIGH Level Input Voltage (Note 2)	1.65 V ≤ V _{CC} < 2.3 V	$0.65 \times V_{CC}$		V
		$2.3 \text{ V} \le \text{V}_{\text{CC}} \le 2.7 \text{ V}$	1.6		1
		2.7 V < V _{CC} ≤ 3.6 V	2.0		1
V _{IL}	LOW Level Input Voltage (Note 2)	1.65 V ≤ V _{CC} < 2.3 V		0.35 x V _{CC}	V
		$2.3 \text{ V} \leq \text{V}_{\text{CC}} \leq 2.7 \text{ V}$		0.7	1
		$2.7 \text{ V} < \text{V}_{\text{CC}} \le 3.6 \text{ V}$		0.8	1
V _{OH}	HIGH Level Output Voltage	$1.65 \text{ V} \le \text{V}_{\text{CC}} \le 3.6 \text{ V}; \text{ I}_{\text{OH}} = -100 \ \mu\text{A}$	V _{CC} – 0.2		V
		V _{CC} = 1.65 V; I _{OH} = -6 mA	1.25		1
		$V_{CC} = 2.3 \text{ V}; \text{ I}_{OH} = -6 \text{ mA}$	2.0	1	1
		V _{CC} = 2.3 V; I _{OH} = -12 mA	1.8	1	1
		V _{CC} = 2.3 V; I _{OH} = -18 mA	1.7	0	1
		V _{CC} = 2.7 V; I _{OH} = -12 mA	2.2	6	1
		V _{CC} = 3.0 V; I _{OH} = -18 mA	2.4		1
		V _{CC} = 3.0 V; I _{OH} = -24 mA	2.2		1
V _{OL}	LOW Level Output Voltage	$1.65 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; \text{ I}_{OL} = 100 \mu\text{A}$		0.2	V
		V _{CC} = 1.65 V; I _{OL} = 6 mA		0.3	1
		V _{CC} = 2.3 V; I _{OL} = 12 mA		0.4	1
		V _{CC} = 2.3 V; I _{OL} = 18 mA		0.6	1
		$V_{CC} = 2.7 \text{ V}; I_{OL} = 12 \text{ mA}$		0.4	1
		V _{CC} = 3.0 V; I _{OL} = 18 mA		0.4	1
		V _{CC} = 3.0 V; I _{OL} = 24 mA		0.55	1
l	Input Leakage Current	$1.65 \text{ V} \le \text{V}_{\text{CC}} \le 3.6 \text{ V}; \text{ 0V} \le \text{V}_1 \le 3.6 \text{ V}$		±5.0	μA
I _{I(HOLD)}	Minimum Bushold Input Current	$V_{CC} = 3.0 \text{ V}, \text{ V}_{IN} = 0.8 \text{ V}$	75		μA
()		V _{CC} = 3.0 V, V _{IN} = 2.0 V	-75		1
		V _{CC} = 2.3 V, V _{IN} = 0.7 V	45		1
	5	V _{CC} = 2.3 V, V _{IN} = 1.6 V	-45		1
		V _{CC} = 1.65 V, V _{IN} = 0. 57 V	25		1
		V _{CC} = 1.65 V, V _{IN} = 1.07 V	-25		1
I (OD)	Minimum Bushold Over-Drive Current	V _{CC} = 3.6 V, (Note 3)	450		μA
()	Minimum Bushold Over–Drive Current Needed to Change State	V _{CC} = 3.6 V, (Note 4)	-450		1
	SV OX	V _{CC} = 2.7 V, (Note 3)	300		1
		V _{CC} = 2.7 V, (Note 4)	-300		1
		V _{CC} = 1.95 V, (Note 3)	200		1
	× •	V _{CC} = 1.95 V, (Note 4)	-200		1
l _{oz}	3-State Output Current	$\begin{array}{l} 1.65 \text{ V} \leq \text{V}_{CC} \leq 3.6 \text{ V}; \text{ 0 V} \leq \text{V}_{O} \leq 3.6 \text{ V}; \\ \text{V}_{I} = \text{V}_{IH} \text{ or } \text{V}_{IL} \end{array}$		±10	μΑ
OFF	Power-Off Leakage Current	V_{CC} = 0 V; V _I or V _O = 3.6 V		10	μA
I _{CC}	Quiescent Supply Current (Note 5)	$1.65 \text{ V} \le \text{V}_{\text{CC}} \le 3.6 \text{ V}; \text{ V}_{\text{I}} = \text{GND or V}_{\text{CC}}$		20	μA
		$1.65 \text{ V} \le \text{V}_{\text{CC}} \le 3.6 \text{ V}; 3.6 \text{ V} \le \text{V}_{\text{I}}, \text{V}_{\text{O}} \le 3.6 \text{ V}$		±20	μA
Δl _{CC}	Increase in I _{CC} per Input	$2.7 \text{ V} < \text{V}_{\text{CC}} \le 3.6 \text{ V}; \text{ V}_{\text{IH}} = \text{V}_{\text{CC}} - 0.6 \text{ V}$		750	μA

These values of V_I are used to test DC electrical characteristics only.
 An external driver must source at least the specified current to switch from LOW-to-HIGH.
 An external driver must source at least the specified current to switch from HIGH-to-LOW.
 Outputs disabled or 3-state only.

					$T_A = -40$	0°C to +85°	С		
			V _{CC} = 3.0	V to 3.6 V	V _{CC} = 2.3	V to 2.7 V	V _{CC} = 1.65	V to 1.95 V	
Symbol	Parameter	Waveform	Min	Max	Min	Max	Min	Max	Unit
t _{PLH} t _{PHL}	Propagation Delay Input-to-Output	1	0.8 0.8	2.5 2.5	1.0 1.0	3.0 3.0	1.5 1.5	6.0 6.0	ns
t _{PZH} t _{PZL}	Output Enable Time to High and Low Level	2	0.8 0.8	3.5 3.5	1.0 1.0	4.1 4.1	1.5 1.5	8.2 8.2	ns
t _{PHZ} t _{PLZ}	Output Disable Time From High and Low Level	2	0.8 0.8	3.5 3.5	1.0 1.0	3.8 3.8	1.5 1.5	7.8 7.8	ns
t _{OSHL} t _{OSLH}	Output-to-Output Skew (Note 7)			0.5 0.5		0.5 0.5		0.75 0.75	ns

AC CHARACTERISTICS (Note 6; $t_R = t_F = 2.0 \text{ ns}$; $C_L = 30 \text{ pF}$; $R_L = 500 \Omega$)

6. For $C_L = 50$ pF, add approximately 300 ps to the AC maximum specification.

 Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}); parameter guaranteed by design.

AC CHARACTERISTICS ($t_R = t_F = 2.0 \text{ ns}$; $C_L = 50 \text{ pF}$; $R_L = 500 \Omega$)

				T _A = -40°C to +85°	С		
			V _{CC} = 3.0	V to 3.6 V	V _{CC} =	2.7 V	
Symbol	Parameter	Waveform	Min	Мах	Min	Max	Unit
t _{PLH} t _{PHL}	Propagation Delay Input-to-Output	3	1.0 1.0	3.9 3.9	NA	5.3 5.3	ns
t _{PZH} t _{PZL}	Output Enable Time to High and Low Level	4	1.0 1.0	5.0 5.0		6.1 6.1	ns
t _{PHZ} t _{PLZ}	Output Disable Time From High and Low Level	4	1.0 1.0	4.4		4.8 4.8	ns
t _{OSHL} t _{OSLH}	Output-to-Output Skew (Note 8)		ILC JK	0.5 0.5		0.5 0.5	ns

8. Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}); parameter guaranteed by design.

DYNAMIC SWITCHING CHARACTERISTICS

			T _A = +25°C	
Symbol	Characteristic	Condition	Тур	Unit
V _{OLP}	Dynamic LOW Peak Voltage	V_{CC} = 1.8 V, C_L = 30 pF, V_{IH} = V_{CC},V_{IL} = 0 V	0.25	V
	(Note 9)	V_{CC} = 2.5 V, C_L = 30 pF, V_{IH} = V_{CC},V_{IL} = 0 V	0.6	
		V_{CC} = 3.3 V, C_L = 30 pF, V_{IH} = V_{CC},V_{IL} = 0 V	0.8	
V _{OLV}	Dynamic LOW Valley Voltage	V_{CC} = 1.8 V, C_L = 30 pF, V_{IH} = V_{CC},V_{IL} = 0 V	-0.25	V
	(Note 9)	V_{CC} = 2.5 V, C_L = 30 pF, V_{IH} = V_{CC},V_{IL} = 0 V	-0.6	
		V_{CC} = 3.3 V, C_L = 30 pF, V_{IH} = V_{CC},V_{IL} = 0 V	-0.8	
V _{OHV}	Dynamic HIGH Valley Voltage	V_{CC} = 1.8 V, C_L = 30 pF, V_{IH} = V_{CC},V_{IL} = 0 V	1.5	V
	(Note 10)	V_{CC} = 2.5 V, C_L = 30 pF, V_{IH} = V_{CC} , V_{IL} = 0 V	1.9	
		V_{CC} = 3.3 V, C_L = 30 pF, V_{IH} = V_{CC} , V_{IL} = 0 V	2.2	

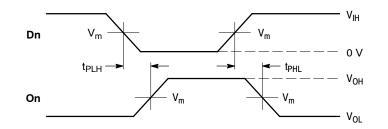
9. Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state.

10. Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the HIGH state.

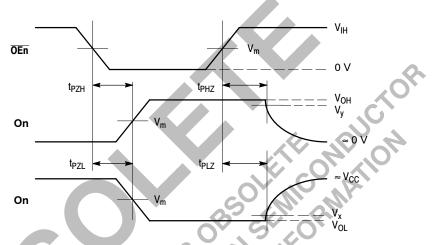
CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Condition	Typical	Unit
C _{IN}	Input Capacitance	Note 11	6	pF
C _{OUT}	Output Capacitance	Note 11	7	pF
C _{PD}	Power Dissipation Capacitance	Note 11, 10 MHz	20	pF
	PLEASE PEPP	Note 11, 10 MHz		

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WAVEFORM 1 – PROPAGATION DELAYS $t_R = t_F = 2.0$ ns, 10% to 90%; f = 1 MHz; $t_W = 500$ ns



WAVEFORM 2 – OUTPUT ENABLE AND DISABLE TIMES $t_R = t_F = 2.0 \text{ ns}, 10\% \text{ to } 90\%; f = 1 \text{ MHz}; t_W = 500 \text{ ns}$

Figure 4. AC Waveforms

Table 2. AC WAVEFORMS

		V _{cc}	
Symbol	3.3 V ± 0.3 V	$\textbf{2.5 V} \pm \textbf{0.2 V}$	1.8 V ± 0.15 V
V _{IH}	2.7 V	V _{CC}	V _{CC}
V _m	1.5 V	V _{CC} /2	V _{CC} /2
V _x	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V
Vy	V _{OH} – 0.3 V	V _{OH} – 0.15 V	V _{OH} – 0.15 V

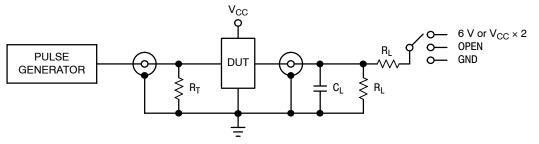
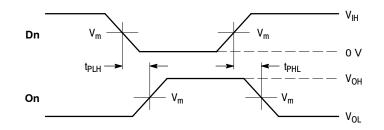


Figure 5. Test Circuit

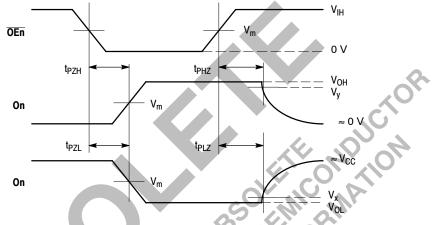
Table 3. TEST CIRCUIT

TEST	SWITCH
tplh, tphl	Open
IPZL, [†] PLZ	
t _{PZH} , t _{PHZ}	GND
C _L = 30 pF or equivalent (Includes jig and R _L = 500 Ω or equivalent R _T = Z _{OUT} of pulse generator (typically 50	Open 6 V at V _{CC} = 3.3 ± 0.3 V; V _{CC} × 2 at V _{CC} = 2.5 ± 0.2 V; 1.8 ± 0.15 V GND probe capacitance) Q)



WAVEFORM 3 - PROPAGATION DELAYS

 t_R = t_F = 2.0 ns, 10% to 90%; f = 1 MHz; t_W = 500 ns



2.7 V

2.7 V

1.5 V

V_{OL} + 0.3 V

V_{OH} – 0.3 V

WAVEFORM 4 - OUTPUT ENABLE AND DISABLE TIMES $t_{\rm F} = t_{\rm F} = 2.0$ ns, 10% to 90%; f = 1 MHz; $t_{\rm W} = 500$ ns

Figure 6. AC Waveforms

1.5 V

V_{OL} + 0.3 V V_{OH} – 0.3 V

Vcc Symbol $3.3 V \pm 0.3 V$ 2.7 V V_{IH}

Table 4. AC WAVEFORMS

Vm

 V_{x}

Vy

21EA

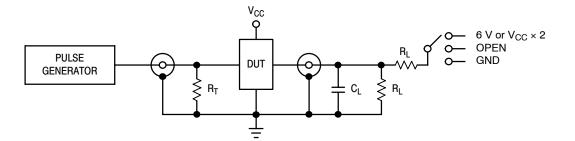


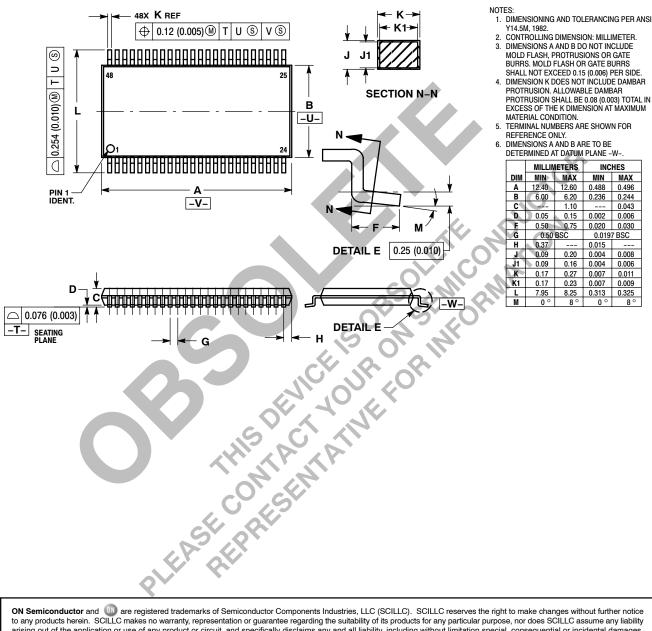


Table 5. TEST CIRCUIT

TEST	SWITCH
t _{PLH} , t _{PHL}	Open
t _{PZL} , t _{PLZ}	
t _{PZH} , t _{PHZ}	GND
$C_L = 50 \text{ pF}$ or equivalent (Includes jig and p $R_L = 500 \Omega$ or equivalent $R_T = Z_{OUT}$ of pulse generator (typically 50	SWITCH Open 6 V at V _{CC} = 3.3 ± 0.3 V; V _{CC} × 2 at V _{CC} = 2.5 ± 0.2 V; 1.8 ± 0.15 V GND probe capacitance) Ω)

PACKAGE DIMENSIONS

TSSOP DT SUFFIX CASE 1201–01 ISSUE A



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